

MTB55N06Z

Preferred Device

Power MOSFET 55 Amps, 60 Volts N-Channel D²PAK

This Power MOSFET is designed to withstand high energy in the avalanche mode and switch efficiently. This high energy device also offers a drain-to-source diode with fast recovery time. Designed for high voltage, high speed switching applications in power supplies, PWM motor controls and other inductive loads, the avalanche energy capability is specified to eliminate the guesswork in designs where inductive loads are switched and offer additional safety margin against unexpected voltage transients.

- Avalanche Energy Capability Specified at Elevated Temperature
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Low Stored Gate Charge for Efficient Switching
- Internal Source-to-Drain Diode Designed to Replace External Zener Transient Suppressor—Absorbs High Energy in the Avalanche Mode
- ESD Protected. Designed to Typically Withstand 400 V Machine Model and 4000 V Human Body Model.

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	60	Vdc
Drain-to-Gate Voltage ($R_{GS} = 1.0\text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate-to-Source Voltage – Continuous – Non-Repetitive ($t_p \leq 10\text{ ms}$)	V_{GS} V_{GSM}	± 20 ± 40	Vdc Vpk
Drain Current – Continuous @ $T_C = 25^\circ\text{C}$ – Continuous @ $T_C = 100^\circ\text{C}$ – Single Pulse ($t_p \leq 10\text{ }\mu\text{s}$)	I_D I_D I_{DM}	55 35.5 165	Adc Adc Apk
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (Note NO TAG)	P_D	113 0.91 2.5	Watts W/ $^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^\circ\text{C}$ ($V_{DD} = 25\text{ Vdc}$, $V_{DS} = 60\text{ Vdc}$, $V_{GS} = 10\text{ Vdc}$, Peak $I_L = 55\text{ Apk}$, $L = 0.3\text{ mH}$, $R_G = 25\text{ }\Omega$)	E_{AS}	454	mJ
Thermal Resistance – Junction to Case – Junction to Ambient – Junction to Ambient (Note NO TAG)	$R_{\theta JC}$ $R_{\theta JC}$ $R_{\theta JA}$	1.1 62.5 50	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	260	$^\circ\text{C}$

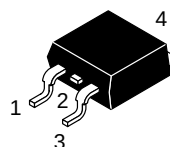
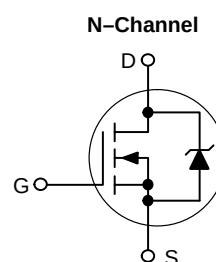
1. When surface mounted to an FR4 board using the minimum recommended pad size.



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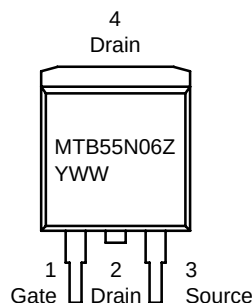
<http://onsemi.com>

**55 AMPERES
60 VOLTS
 $R_{DS(on)} = 18\text{ m}\Omega$**



**D2PAK
CASE 418B
STYLE 2**

MARKING DIAGRAM & PIN ASSIGNMENT



MTB55N06Z = Device Code
Y = Year
WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping
MTB55N06Z	D ² PAK	50 Units/Rail
MTB55N06ZT4	D ² PAK	800/Tape & Reel

Preferred devices are recommended choices for future use and best overall value.

MTB55N06Z

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage ($V_{GS} = 0\text{ Vdc}$, $I_D = 250\text{ }\mu\text{Adc}$) Temperature Coefficient (Positive)	$V_{(BR)DSS}$	60 –	– 53	– –	Vdc mV/ $^\circ\text{C}$
Zero Gate Voltage Drain Current ($V_{DS} = 60\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) ($V_{DS} = 60\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$, $T_J = 125^\circ\text{C}$)	I_{DSS}	– –	– –	1.0 10	μAdc
Gate-Body Leakage Current ($V_{GS} = \pm 20\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	–	–	100	nAdc

ON CHARACTERISTICS (Note 2.)

Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{Adc}$) Threshold Temperature Coefficient (Negative)	$V_{GS(th)}$	2.0 –	3.0 6.0	4.0 –	Vdc mV/ $^\circ\text{C}$
Static Drain-to-Source On-Resistance ($V_{GS} = 10\text{ Vdc}$, $I_D = 27.5\text{ Adc}$)	$R_{DS(on)}$	–	14	18	m Ω
Drain-to-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$) ($I_D = 55\text{ Adc}$) ($I_D = 27.5\text{ Adc}$, $T_J = 125^\circ\text{C}$)	$V_{DS(on)}$	– –	0.825 0.74	1.2 1.0	Vdc
Forward Transconductance ($V_{DS} = 4.0\text{ Vdc}$, $I_D = 27.5\text{ Adc}$)	g_{FS}	12	15	–	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	$(V_{DS} = 25\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$, $f = 1.0\text{ MHz}$)	C_{iss}	–	1390	1950	pF
Output Capacitance		C_{oss}	–	520	730	
Transfer Capacitance		C_{rss}	–	119	238	

SWITCHING CHARACTERISTICS (Note 3.)

Turn-On Delay Time	$(V_{DD} = 30\text{ Vdc}$, $I_D = 55\text{ Adc}$, $V_{GS(on)} = 10\text{ Vdc}$, $R_G = 9.1\text{ }\Omega$)	$t_{d(on)}$	–	27	54	ns
Rise Time		t_r	–	157	314	
Turn-Off Delay Time		$t_{d(off)}$	–	116	232	
Fall Time		t_f	–	126	252	
Gate Charge (See Figure 8)	$(V_{DS} = 48\text{ Vdc}$, $I_D = 55\text{ Adc}$, $V_{GS} = 10\text{ Vdc}$)	Q_T	–	40	56	nC
		Q_1	–	7.0	–	
		Q_2	–	18	–	
		Q_3	–	15	–	

SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage	$(I_S = 55\text{ Adc}$, $V_{GS} = 0\text{ Vdc}$) $(I_S = 55\text{ Adc}$, $V_{GS} = 0\text{ Vdc}$, $T_J = 125^\circ\text{C}$)	V_{SD}	– –	0.93 0.82	1.1 –	Vdc
Reverse Recovery Time	$(I_S = 55\text{ Adc}$, $V_{GS} = 0\text{ Vdc}$, $dI_S/dt = 100\text{ A}/\mu\text{s}$)	t_{rr}	–	57	–	ns
		t_a	–	32	–	
		t_b	–	25	–	
Reverse Recovery Stored Charge		Q_{RR}	–	0.11	–	μC

INTERNAL PACKAGE INDUCTANCE

Internal Drain Inductance (Measured from contact screw on tab to center of die) (Measured from drain lead 0.25" from package to center of die)	L_D	– –	3.5 4.5	– –	nH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad)	L_S	–	7.5	–	

- Pulse Test: Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycle $\leq 2\%$.
- Switching characteristics are independent of operating junction temperature.

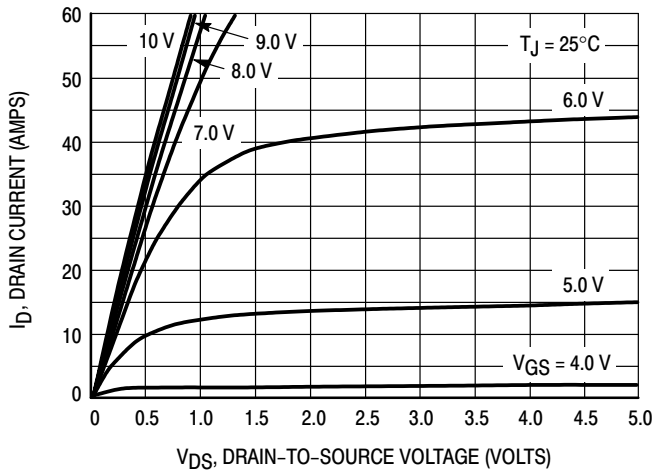


Figure 1. On-Region Characteristics

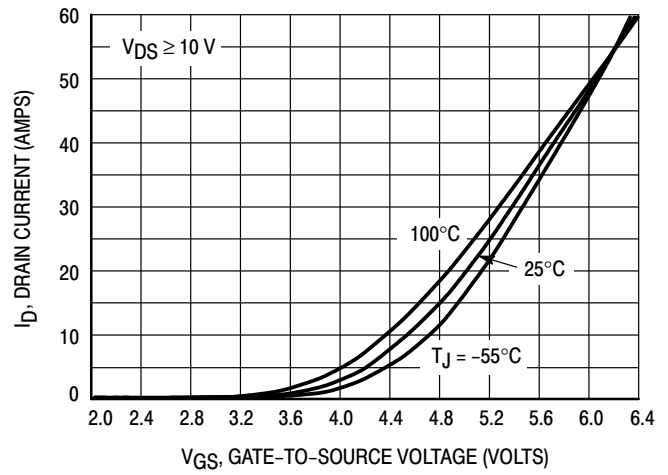


Figure 2. Transfer Characteristics

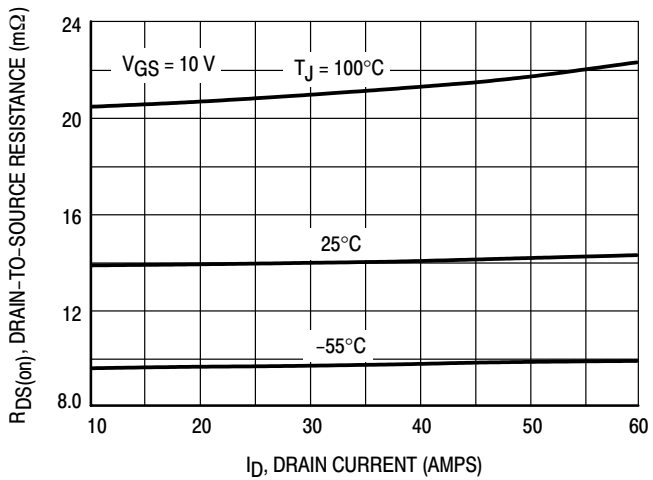


Figure 3. On-Resistance versus Drain Current and Temperature

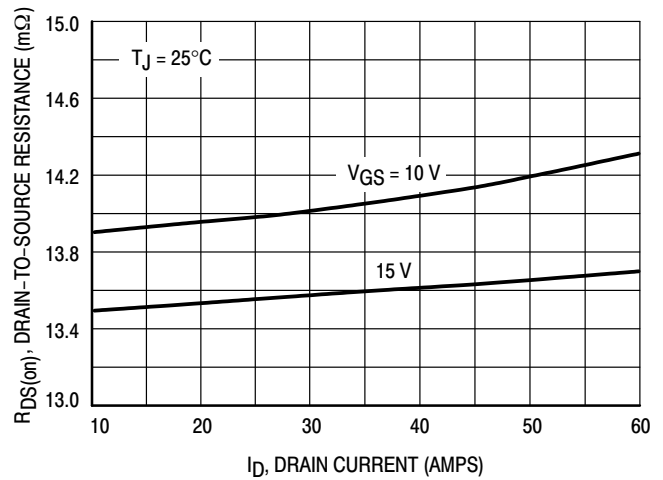


Figure 4. On-Resistance versus Drain Current and Gate Voltage

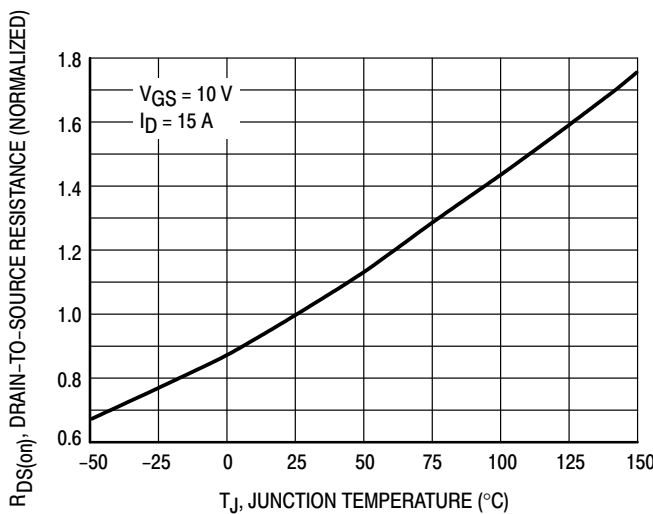


Figure 5. On-Resistance Variation with Temperature

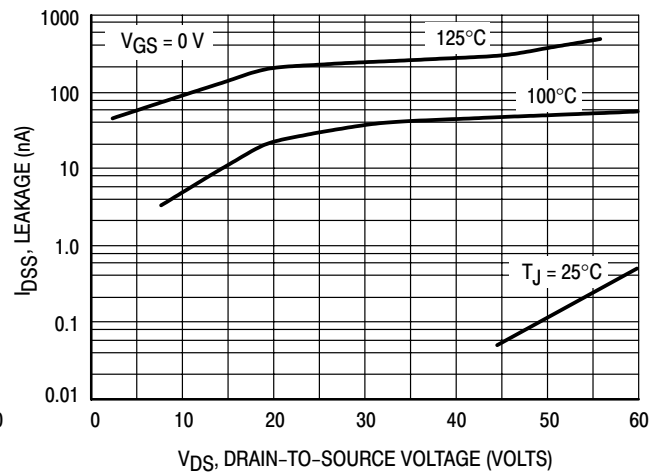
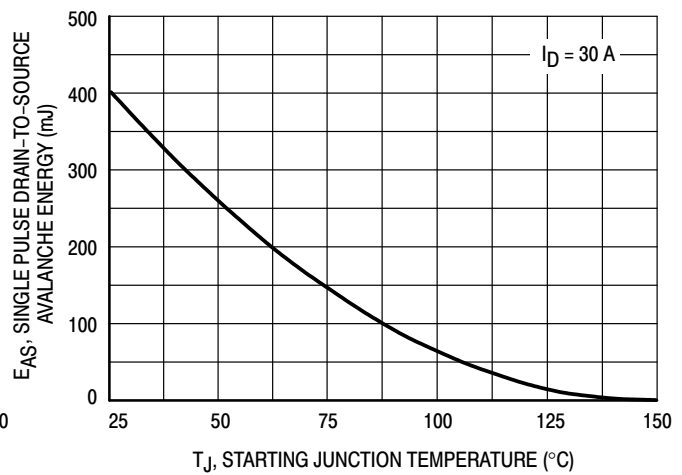
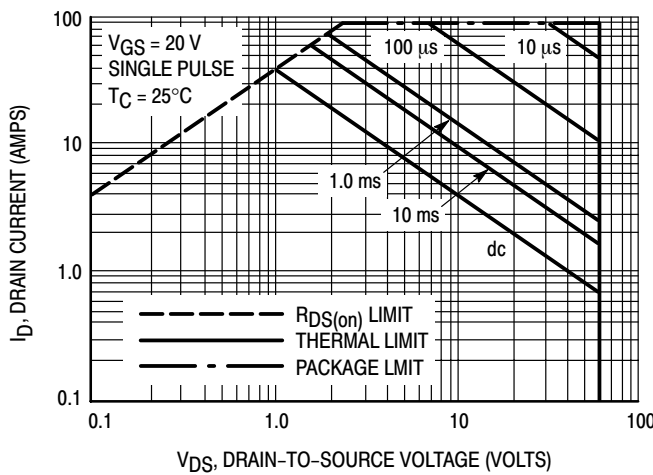
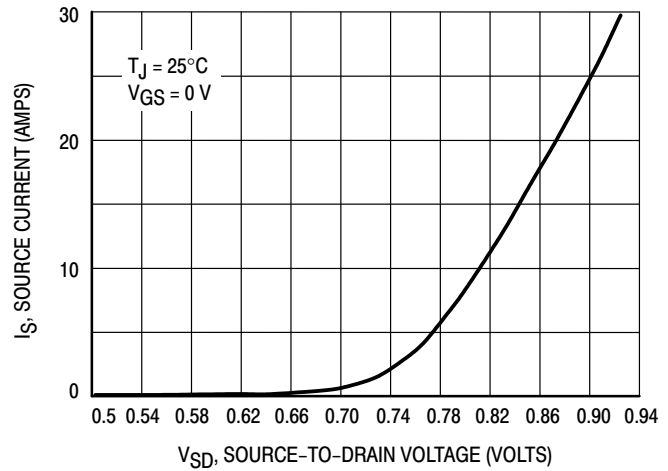
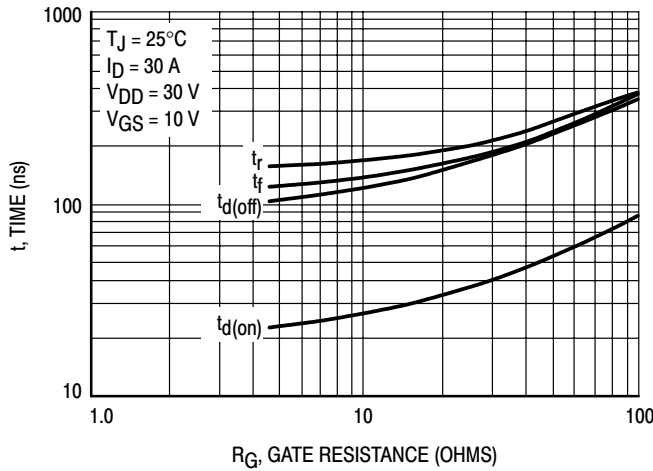
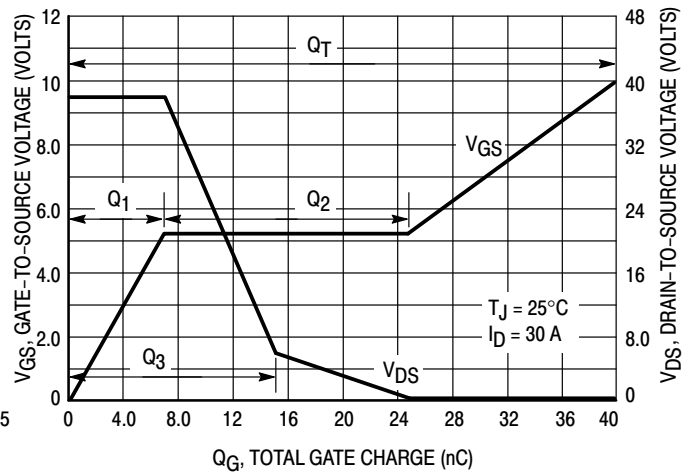
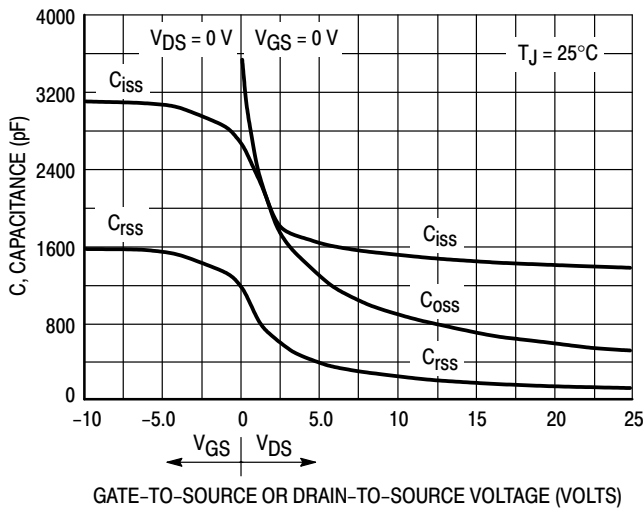


Figure 6. Drain-to-Source Leakage Current versus Voltage



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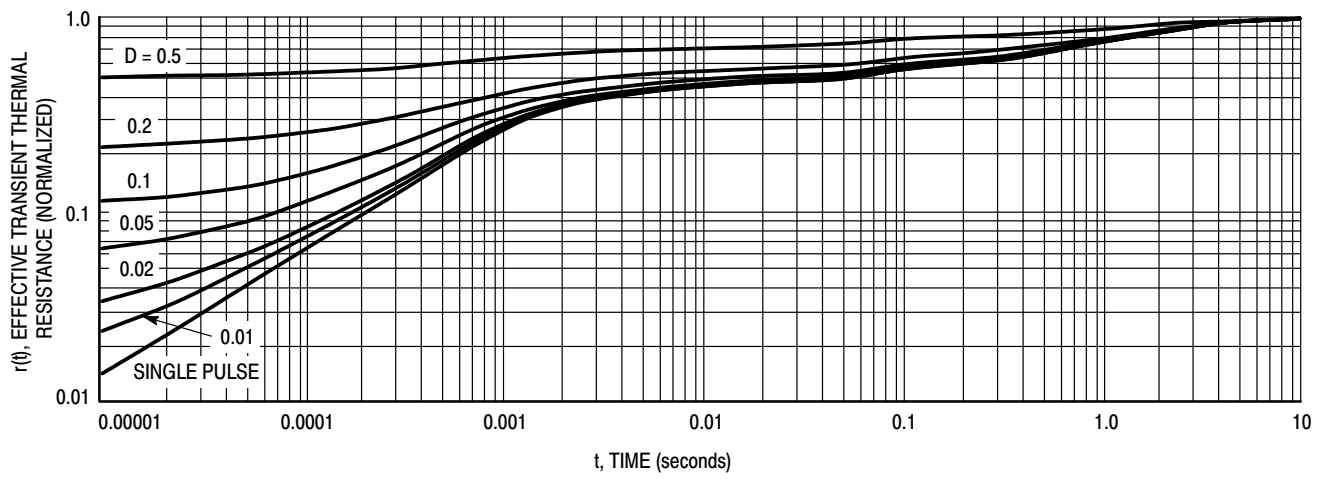
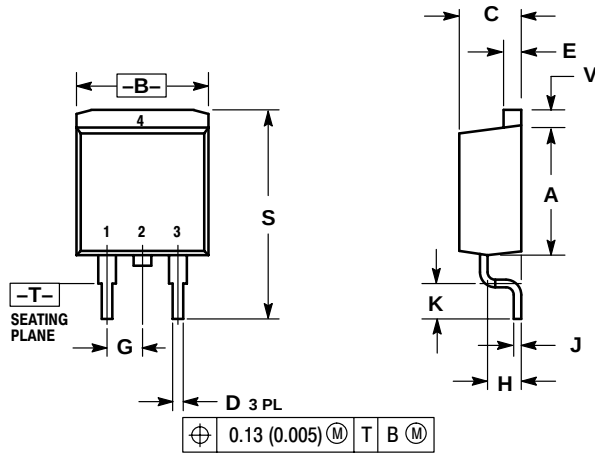


Figure 13. Thermal Response

MTB55N06Z

PACKAGE DIMENSIONS

D²PAK
CASE 418B-03
ISSUE D



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.340	0.380	8.64	9.65
B	0.380	0.405	9.65	10.29
C	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
E	0.045	0.055	1.14	1.40
G	0.100 BSC		2.54 BSC	
H	0.080	0.110	2.03	2.79
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
S	0.575	0.625	14.60	15.88
V	0.045	0.055	1.14	1.40

- STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

Notes

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